

Notice of References Cited	Application/Control No. 09/676,645	Applicant(s)/Patent Under Reexamination YAMADA ET AL	
	Examiner HUY T. NGUYEN	Art Unit 2616	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	EP 0858171 A2	08-1998	EP	Yonemitsu et al	-----
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NON-PATENT DOCUMENTS

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